Search Notes

Application/Control N	o. Applicant(s)/Patent under Reexamination		
10/790,248	YONEDA, KIYOSHI		
Examiner	Art Unit		
Chuc D. Tran	2821		

SEARCHED					
Class	Subclass	Date	Examiner		
315	169.3	9/25/2006	тс		
315	169.1	9/25/2006	тс		
315	169.2	9/25/2006	TC		
345	87,92	9/25/2006	TC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
BRS		9/25/2006	тс